



FDP3205

N-Channel PowerTrench[®] MOSFET

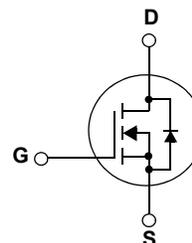
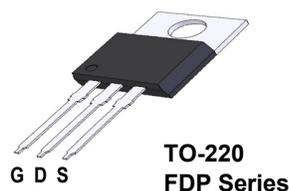
55V, 100A, 7.5mΩ

Features

- $R_{DS(on)} = 6.1m\Omega$ (Typ.) @ $V_{GS} = 10V, I_D = 59A$
- High performance trench technology for extremely low $R_{DS(on)}$
- High power and current handling capability
- RoHS compliant

Description

- This N-Channel MOSFET is produced using Fairchild Semiconductor's advanced PowerTrench process that has been especially tailored to minimize the on-state resistance and yet maintain superior switching performance.



MOSFET Maximum Ratings $T_C = 25^\circ C$ unless otherwise noted

Symbol	Parameter		Ratings	Units
V_{DSS}	Drain to Source Voltage		55	V
V_{GSS}	Gate to Source Voltage		± 20	V
I_D	Drain Current	-Continuous ($T_C = 25^\circ C$) (Note 1)	100	A
I_{DM}	Drain Current	- Pulsed	390	A
E_{AS}	Single Pulsed Avalanche Energy (Note 2)		365	mJ
P_D	Power Dissipation	($T_C = 25^\circ C$)	150	W
		- Derate above $25^\circ C$	1.0	W/ $^\circ C$
T_J, T_{STG}	Operating and Storage Temperature Range		-55 to +175	$^\circ C$

Thermal Characteristics

Symbol	Parameter	Ratings	Units
$R_{\theta JC}$	Thermal Resistance, Junction to Case	1.0	$^\circ C/W$
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	62.5	

Package Marking and Ordering Information $T_C = 25^\circ\text{C}$ unless otherwise noted

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDP3205	FDP3205	TO-220	-	-	50units

Electrical Characteristics

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
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Off Characteristics

BV_{DSS}	Drain to Source Breakdown Voltage	$I_D = 250\mu\text{A}, V_{GS} = 0\text{V}, T_J = 25^\circ\text{C}$	55	-	-	V
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 44\text{V}, V_{GS} = 0\text{V}$	-	-	25	μA
		$V_{DS} = 44\text{V}, T_C = 150^\circ\text{C}$	-	-	250	
I_{GSS}	Gate to Body Leakage Current	$V_{GS} = \pm 20\text{V}, V_{DS} = 0\text{V}$	-	-	± 100	nA

On Characteristics

$V_{GS(th)}$	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250\mu\text{A}$	3.5	-	5.5	V
$R_{DS(on)}$	Static Drain to Source On Resistance	$V_{GS} = 10\text{V}, I_D = 59\text{A}$	-	6.1	7.5	m Ω
		$V_{GS} = 10\text{V}, I_D = 59\text{A}$ $T_J = 175^\circ\text{C}$	-	12	-	

Dynamic Characteristics

C_{iss}	Input Capacitance	$V_{DS} = 25\text{V}, V_{GS} = 0\text{V}$ $f = 1\text{MHz}$	-	5810	7730	pF
C_{oss}	Output Capacitance		-	460	610	pF
C_{rss}	Reverse Transfer Capacitance		-	230	345	pF
R_G	Gate Resistance	$V_{GS} = 0\text{V}, f = 1\text{MHz}$	3	4	5	Ω
$Q_{g(tot)}$	Total Gate Charge at 10V	$V_{GS} = 0\text{V to } 10\text{V}$	-	93	120	nC
$Q_{g(th)}$	Threshold Gate Charge	$V_{GS} = 0\text{V to } 2\text{V}$	-	25.5	33	nC
Q_{gs}	Gate to Source Gate Charge	$V_{DS} = 44\text{V}$ $I_D = 59\text{A}$ $I_g = 1\text{mA}$	-	35	-	nC
Q_{gs2}	Gate Charge Threshold to Plateau		-	9.5	-	nC
Q_{gd}	Gate to Drain "Miller" Charge		-	32	-	nC

Switching Characteristics

t_{ON}	Turn-On Time	$V_{DD} = 28\text{V}, I_D = 59\text{A}$ $V_{GS} = 10\text{V}, R_{GEN} = 2.5\Omega$	-	170	350	ns
$t_{d(on)}$	Turn-On Delay Time		-	23	56	ns
t_r	Turn-On Rise Time		-	147	305	ns
$t_{d(off)}$	Turn-Off Delay Time		-	42	94	ns
t_f	Turn-Off Fall Time		-	18	46	ns
t_{OFF}	Turn-Off Time		-	60	130	ns

Drain-Source Diode Characteristics

V_{SD}	Drain to Source Diode Forward Voltage	$V_{GS} = 0\text{V}, I_{SD} = 59\text{A}$	-	-	1.3	V
t_{rr}	Reverse Recovery Time	$V_{GS} = 0\text{V}, I_{SD} = 59\text{A}$	-	43.3	-	ns
Q_{rr}	Reverse Recovery Charge	$di_F/dt = 100\text{A}/\mu\text{s}$	-	70.8	-	nC

Notes:

- 1: Calculated continuous current based on maximum allowable junction temperature. Package limited to 75A continuous, see Figure 9.
- 2: $L = 0.21\text{mH}, I_{AS} = 59\text{A}, V_{DD} = 50\text{V}, V_{GS} = 10\text{V}, R_G = 25\Omega$, Starting $T_J = 25^\circ\text{C}$

Typical Performance Characteristics

Figure 1. On-Region Characteristics

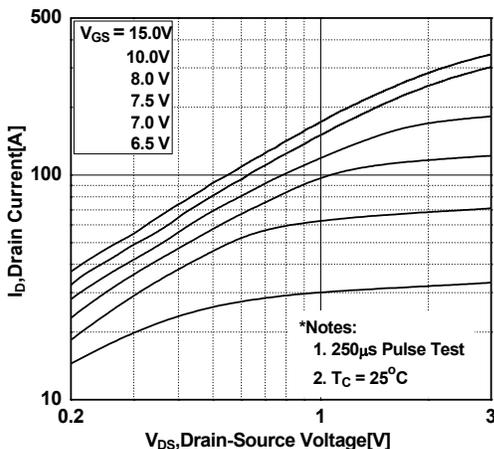


Figure 2. Transfer Characteristics

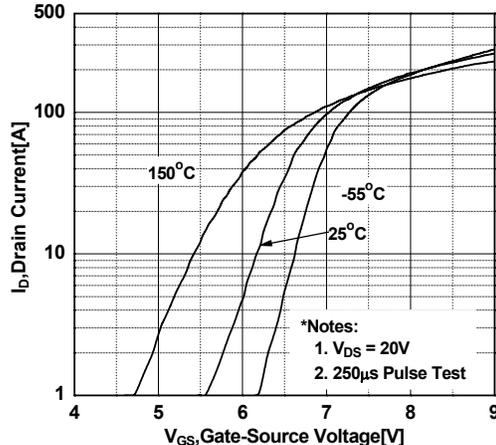


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

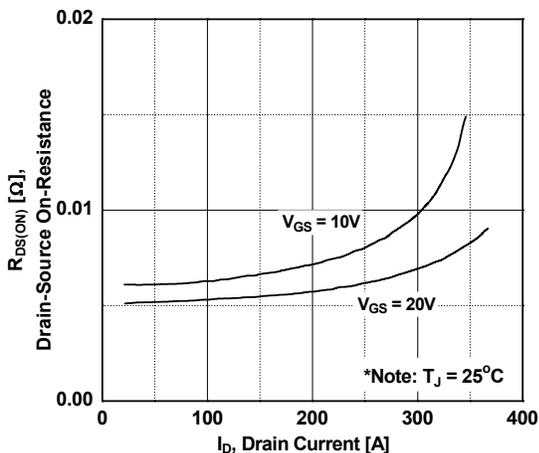


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

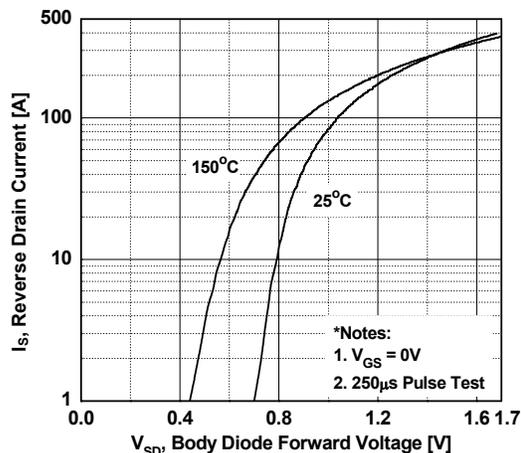


Figure 5. Capacitance Characteristics

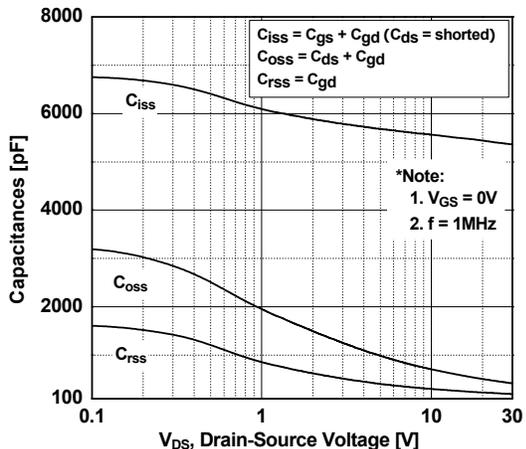


Figure 6. Gate Charge Characteristics

